

April 1994 Revised January 2000

74VHC4066 Quad Analog Switch

General Description

These devices are digitally controlled analog switches utilizing advanced silicon-gate CMOS technology. These switches have low "on" resistance and low "off" leakages. They are bidirectional switches, thus any analog input may be used as an output and visa-versa. Also the 4066 switches contain linearization circuitry which lowers the "on" resistance and increases switch linearity. The 4066 devices allow control of up to 12V (peak) analog signals with digital control signals of the same range. Each switch has its own control input which disables each switch when low. All analog inputs and outputs and digital inputs are protected from electrostatic damage by diodes to $\rm V_{CC}$ and around.

Features

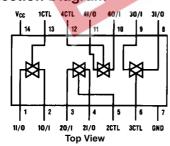
- Typical switch enable time: 15 ns
- Wide analog input voltage range: 0–12V
- Low "on" resistance: 30 typ. ('4066)
- Low quiescent current: 80 µA maximum (74VHC)
- Matched switch characteristics
- Individual switch controls
- Pin and function compatible with the 74HC4066

Ordering Code:

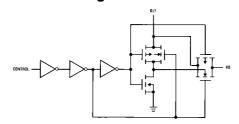
Order Number	Package Number	Package Description
74VHC4066M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74VHC4066MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74VHC4066N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Schematic Diagram



Truth Table

Input	Switch
CTL	I/O-O/I
L	"OFF"
Н	"ON"

Absolute Maximum Ratings(Note 1)

(Note 2)

-0.5 to +15V
-1.5 to $V_{CC} + 1.5V$
$V_{\mbox{\footnotesize EE}} - 0.5$ to $V_{\mbox{\footnotesize CC}} + 0.5 \mbox{\footnotesize V}$
±20 mA
±25 mA
±50 mA
-65°C to +150°C
600 mW
500 mW
260°C

Recommended Operating Conditions

	Min	Max	Units
Supply Voltage (V _{CC})	2	12	V
DC Input or Output Voltage	0	V_{CC}	V
(V_{IN}, V_{OUT})			
Operating Temperature Range (T _A)	-40	+85	°C
Input Rise or Fall Times (t _r , t _f)			
$V_{CC} = 2.0V$		1000	ns
$V_{CC} = 4.5V$		500	ns
$V_{CC} = 9.0V$		400	ns

Note 1: Absolute Maximum Ratings are those values beyond which damage to the device may occur.

260°C Note 2: Unless otherwise specified all voltages are referenced to ground. Note 3: Power Dissipation temperature derating — plastic "N" package: – 12 mW/°C from 65°C to 85°C.

DC Electrical Characteristics (Note 4)

	Parameter	Conditions	V _{CC}	T _A =25°C		T _A =-40 to 85°C	
Symbol				Тур	Guarar	nteed Limits	Units
V _{IH}	Minimum HIGH Level	1	2.0V		1.5	1.5	V
	Input Voltage	36.	4.5V	400	3.15	3.15	V
		N.S.	9.0V	60.	6.3	5.3	V
			12.0V		8.4	8.4	V
V _{IL}	Maximum LOW Level		2.0V		0.5	0.5	V
	Input Voltage		4.5V		1.35	1.35	V
			9.0V		2.7	2.7	V
			12.0V	l	3.6	3.6	V
R _{ON}	Maximum "ON" Resistance	$V_{CTL} = V_{IH}$, $I_S = 2.0 \text{ mA}$	4.5V	100	170	200	Ω
	See (Note 5)	V _{IS} = V _{CC} to GND	9.0V	50	85	105	Ω
		(Figure 1)	12.0V	30	70	85	Ω
			2.0V	120	180	215	Ω
		$V_{CTL} = V_{IH}$, $I_S = 2.0 \text{ mA}$	4.5V	50	80	100	Ω
		$V_{IS} = V_{CC}$ or GND	9.0V	35	60	75	Ω
		(Figure 1)	12.0V	20	40	60	Ω
R _{ON}	Maximum "ON" Resistance	V _{CTL} = V _{IH}	4.5V	10	15	20	Ω
	Matching	$V_{IS} = V_{CC}$ to GND	9.0V	5	10	15	Ω
			12.0V	5	10	15	Ω
I _{IN}	Maximum Control	V _{IN} = V _{CC} or GND			±0.05	±0.5	μΑ
	Input Current	$V_{CC} = 2 - 6V$	'				i
I _{IZ}	Maximum Switch "OFF"	$V_{OS} = V_{CC}$ or GND	6.0V	10	±60	±600	nA
	Leakage Current	$V_{IS} = GND \text{ or } V_{CC}$	9.0V	15	±80	±800	nA
		V _{CTL} = V _{IL} (Figure 2)	12.0V	20	±100	±1000	nA
I _{IZ}	Maximum Switch "ON"	$V_{IS} = V_{CC}$ to GND	6.0V	10	±40	±150	nA
	Leakage Current	$V_{CTL} = V_{IH}$	9.0V	15	±50	±200	nA
		V _{OS} = OPEN (Figure 3)	12.0V	20	±60	±300	nA
Icc	Maximum Quiescent	$V_{IN} = V_{CC}$ or GND	6.0V		1.0	10	μΑ
	Supply Current	$I_{OUT} = 0 \mu A$	9.0V		2.0	20	μΑ
		'	12.0V		4.0	40	μΑ

Note 4: For a power supply of $5V \pm 10\%$ the worst case on resistance (R_{ON}) occurs for VHC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at $V_{CC} = 5.5V$ and 4.5V respectively. (The V_{IH} value at 5.5V is 3.85V.) The worst case leakage current occurs for CMOS at the higher voltage and so the 5.5V values should be used.

Note 5: At supply voltages (V_{CC} – GND) approaching 2V the analog switch on resistance becomes extremely non-linear. Therefore it is recommended that these devices be used to transmit digital only when using these supply voltages.

AC Electrical Characteristics

 $V_{CC} = 2.0V - 6.0V V_{EE} = 0V - 12V, C_L = 50 pF (unless otherwise specified)$

Symbol	Parameter	Conditions	v _{cc}	T _A =25°C		T _A =-40 to 85°C	Units
Symbol		Conditions		Тур	Guaran	teed Limits	Units
t _{PHL} , t _{PLH}	Maximum Propagation		3.3V	25	30	20	ns
	Delay Switch In to Out		4.5V	5	10	13	ns
			9.0V	4	8	10	ns
			12.0V	3	7	11	ns
t _{PZL} , t _{PZH}	Maximum Switch Turn	$R_L = 1 k\Omega$	3.3V	30	58	73	ns
	"ON" Delay		4.5V	12	20	25	ns
			9.0V	6	12	15	ns
			12.0V	5	10	13	ns
t _{PHZ} , t _{PLZ}	Maximum Switch Turn	$R_L = 1 \text{ k}\Omega$	3.3V	60	100	125	ns
	"OFF" Delay		4.5V	25	36	45	ns
			9.0V	20	32	40	ns
			12.0V	15	30	38	
	Minimum Frequency	$R_L = 600\Omega$	4.5V	40			MHz
	Response (Figure 7)	$V_{IS} = 2 V_{PP}$ at $(V_{CC}/2)$	9.0V	100	-0		MHz
	$20 \log(V_O/V_I) = -3 dB$	(Note 6)(Note 7)			7 15		
	Crosstalk Between	$R_L = 600\Omega$, $F = 1 MHz$		4.	10	-	
	any Two Switches	(Note 7)(Note 8)	4.5V	-52			dB
	(Figure 8)		9.0V 🦓	-50			dB
	Peak Control to Switch	$R_L = 600\Omega$, $F = 1 MHz$	4.5V	100	10		mV
	Feedthrough Noise	C _L = 50 pF	9.0V	250			mV
	(Figure 9)						
	Switch OFF Signal	$R_L = 600\Omega$, $F = 1 MHz$	1				
	Feedthrough	$V_{(CT)}V_{IL}$					
	Isolation	(Note 7)(Note 8)	4.5V	-42			dB
	(Figure 10)		9.0V	-44			dB
THD	Total Harmonic	$R_L = 10 \text{ k}\Omega, C_L = 50 \text{ pF},$					
	Distortion	F = 1 kHz					
	(Figure 11)	V _{IS} = 4 V _{PP}	4.5V	.013			%
		$V_{iS} = 8 V_{PP}$	9.0V	.008			%
C _{IN}	Maximum Control			5	10	10	pF
	Input Capacitance						
C _{IN}	Maximum Switch			20			pF
	Input Capacitance						
C _{IN}	Maximum Feedthrough	V _{CTL} = GND		0.5			pF
	Capacitance						
C _{PD}	Power Dissipation			15			pF
	Capacitance						

Note 6: Adjust 0 dBm for F = 1 kHz (Null R_L/R_{ON} Attenuation).

Note 7: V_{IS} is centered at $V_{CC}/2$.

Note 8: Adjust input for 0 dBm.

AC Test Circuits and Switching Time Waveforms

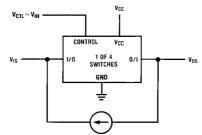
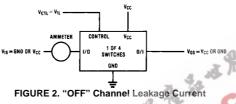


FIGURE 1. "ON" Resistance



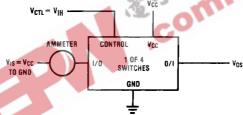


FIGURE 3. "ON" Channel Leakage Current



FIGURE 4. $t_{\text{PHL}}, t_{\text{PLH}}$ Propagation Delay Time Signal Input to Signal Output

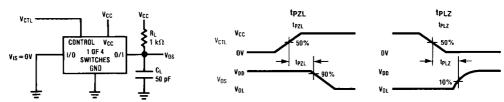


FIGURE 5. $t_{\mbox{\scriptsize PZL}}, t_{\mbox{\scriptsize PLZ}}$ Propagation Delay Time Control to Signal Output

AC Test Circuits and Switching Time Waveforms (Continued)

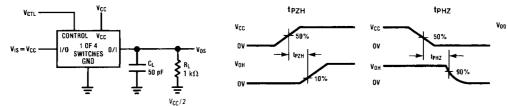


FIGURE 6. t_{PZH} , t_{PHZ} Propagation Delay Time Control to Signal Output

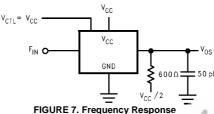


FIGURE 7. Frequency Response

Crosstalk and Distortion Test Circuits

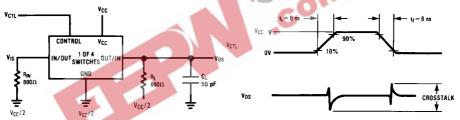


FIGURE 8. Crosstalk: Control Input to Signal Output

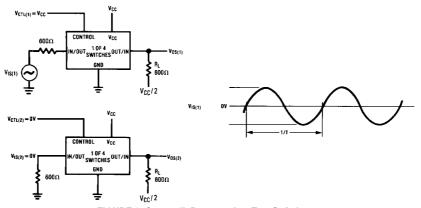


FIGURE 9. Crosstalk Between Any Two Switches

Crosstalk and Distortion Test Circuits (Continued)

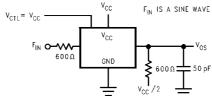


FIGURE 10. Switch OFF Signal Feedthrough Isolation

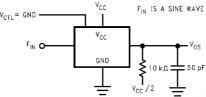
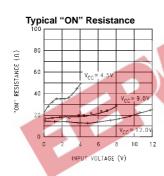
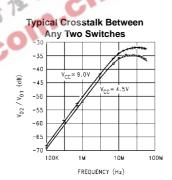
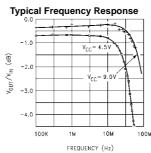


FIGURE 11. Sinewave Distortion

Typical Performance Characteristics

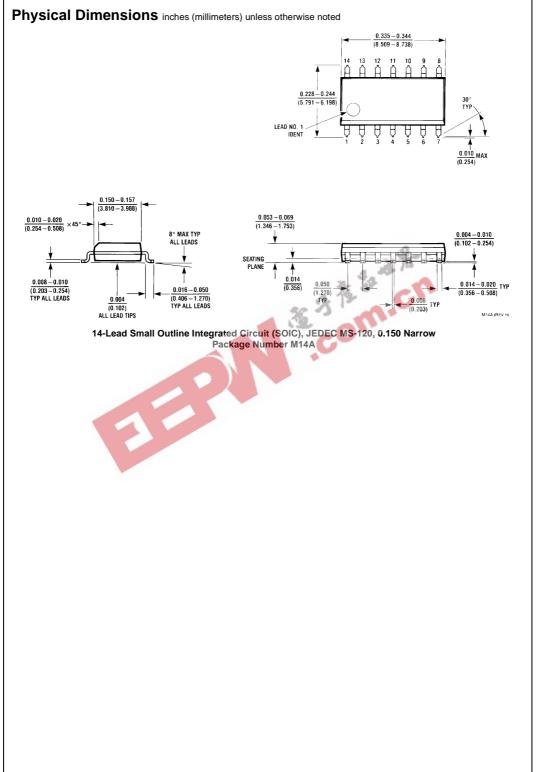


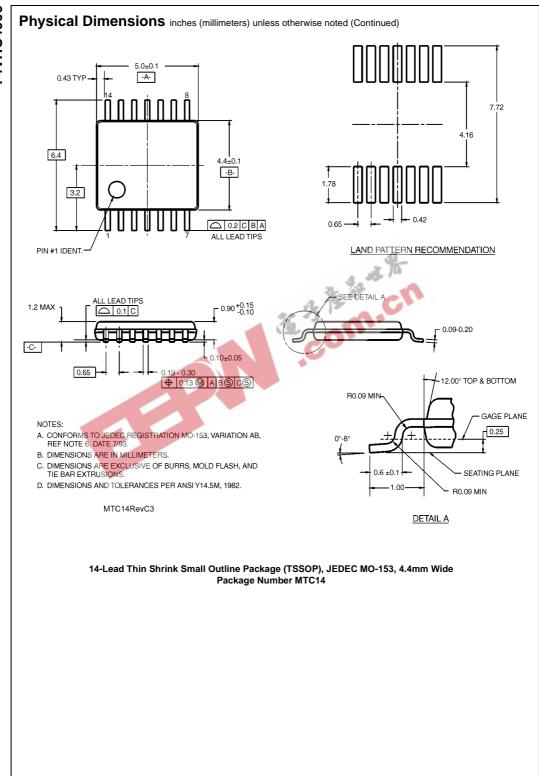


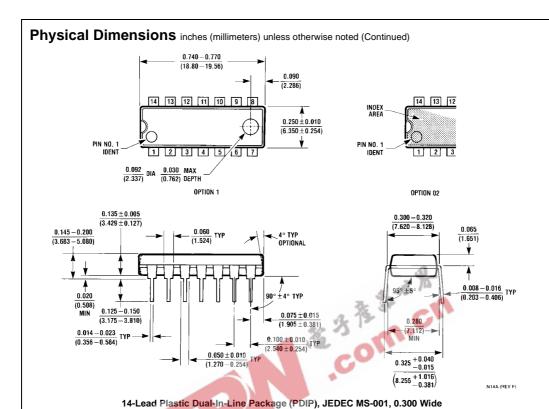


Special Considerations

In certain applications the external load-resistor current may include both V_{CC} and signal line components. To avoid drawing V_{CC} current when switch current flows into the analog switch input pins, the voltage drop across the switch must not exceed 0.6V (calculated from the ON resistance).







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Package Number N14A

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